

**Supporting Information**

**Phase Segregation Assisted Morphology Sculpting - Growth of Graphite and Silicon Crystals via Vapor-Solid Reactions**

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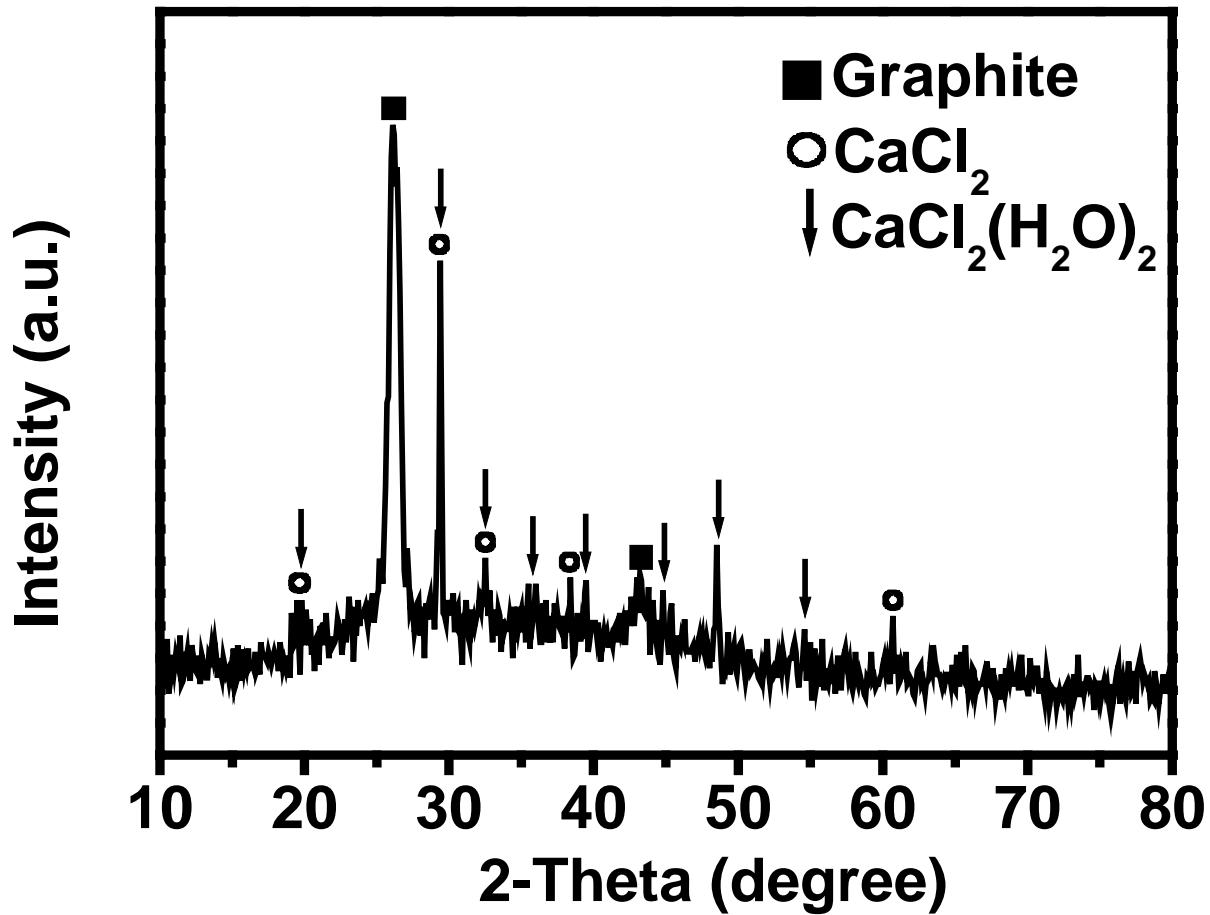
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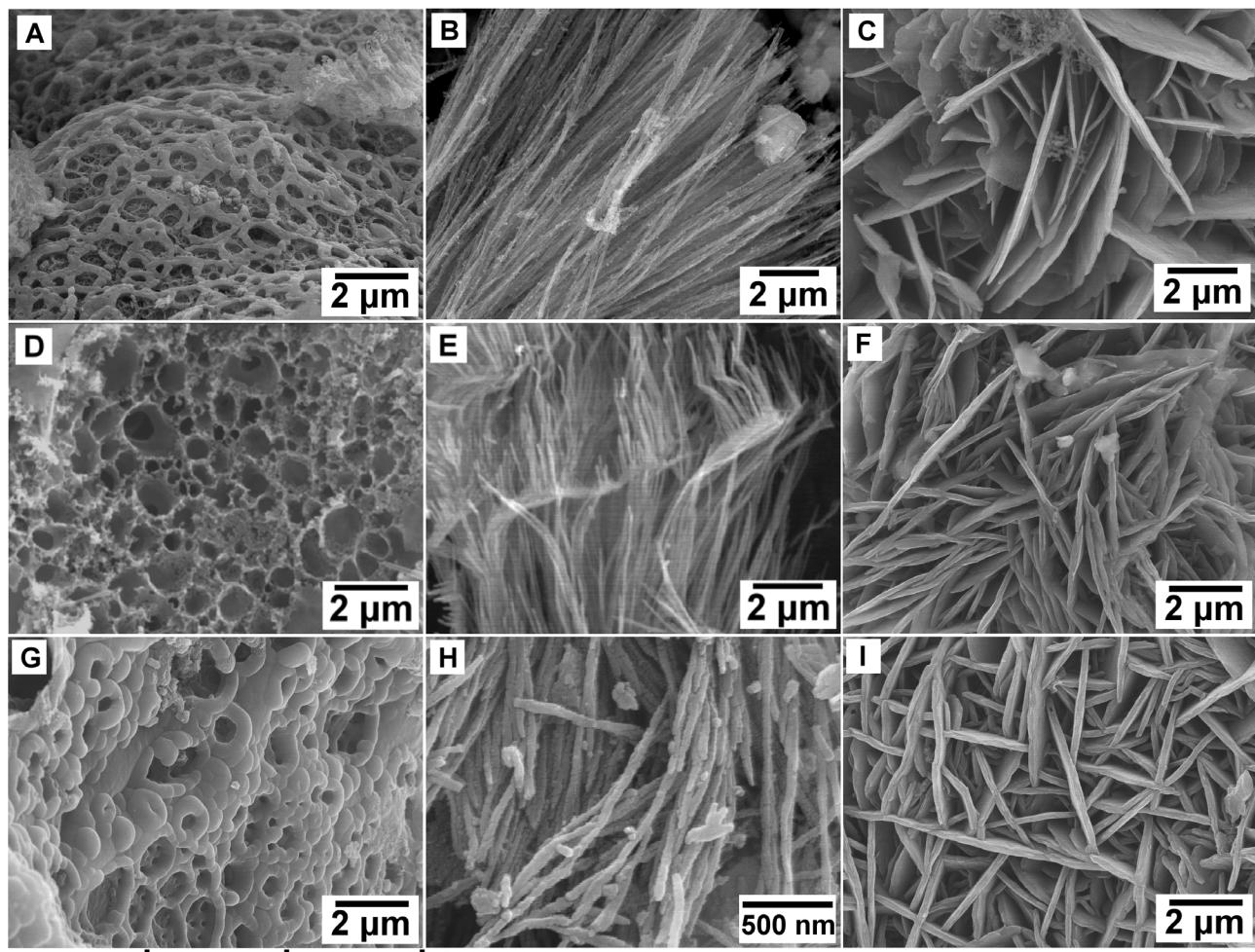
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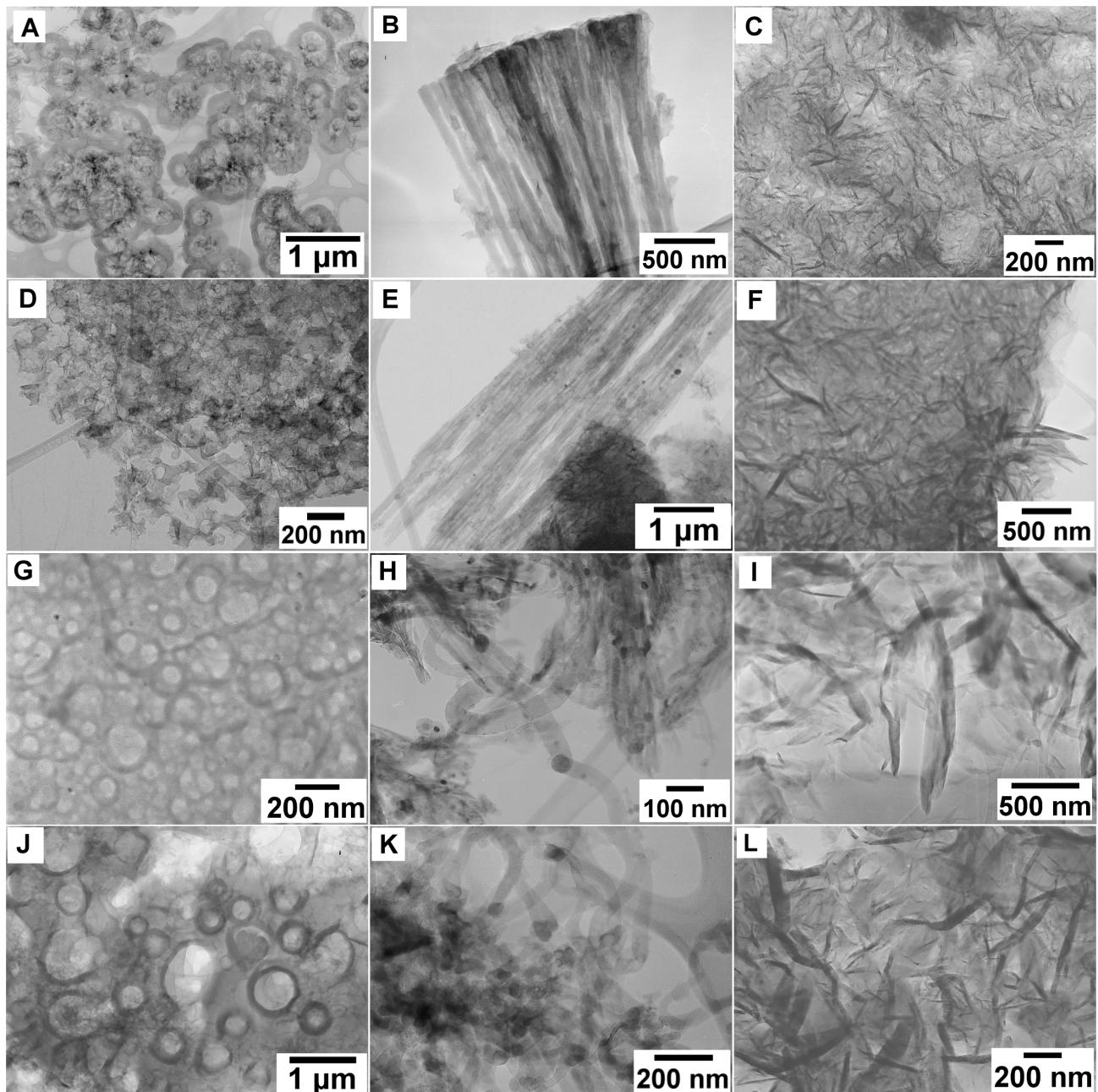


**Figure S1.** XRD of products grown from CaC<sub>2</sub> and C<sub>4</sub>Cl<sub>6</sub> at 1223 K showing formation of graphite and CaCl<sub>2</sub>(H<sub>2</sub>O)<sub>x</sub>. JCPDS file number: graphite:23-0064, CaCl<sub>2</sub>: 74-0522, CaCl<sub>2</sub>(H<sub>2</sub>O)<sub>2</sub>: 70-0385.



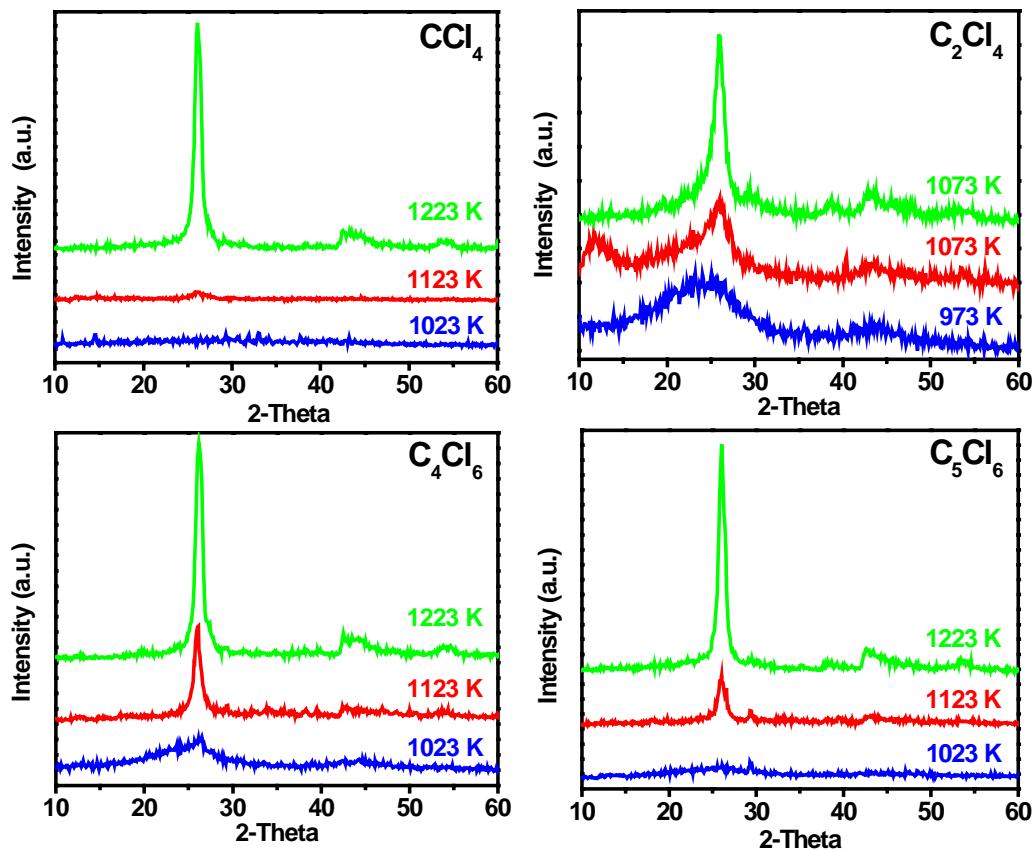
	(A)	(B)	(C)
$\text{CCl}_4$	1023 K	1123 K	1223 K
$\text{C}_2\text{Cl}_4$	(D) 973 K	(E) 1023 K	(F) 1123 K
$\text{C}_5\text{Cl}_6$	(G) 1023 K	(H) 1123 K	(I) 1223 K

**Figure S2.** SEM images of graphite products prepared from  $\text{CaC}_2$  and  $\text{C}_x\text{Cl}_y$  at different temperatures.

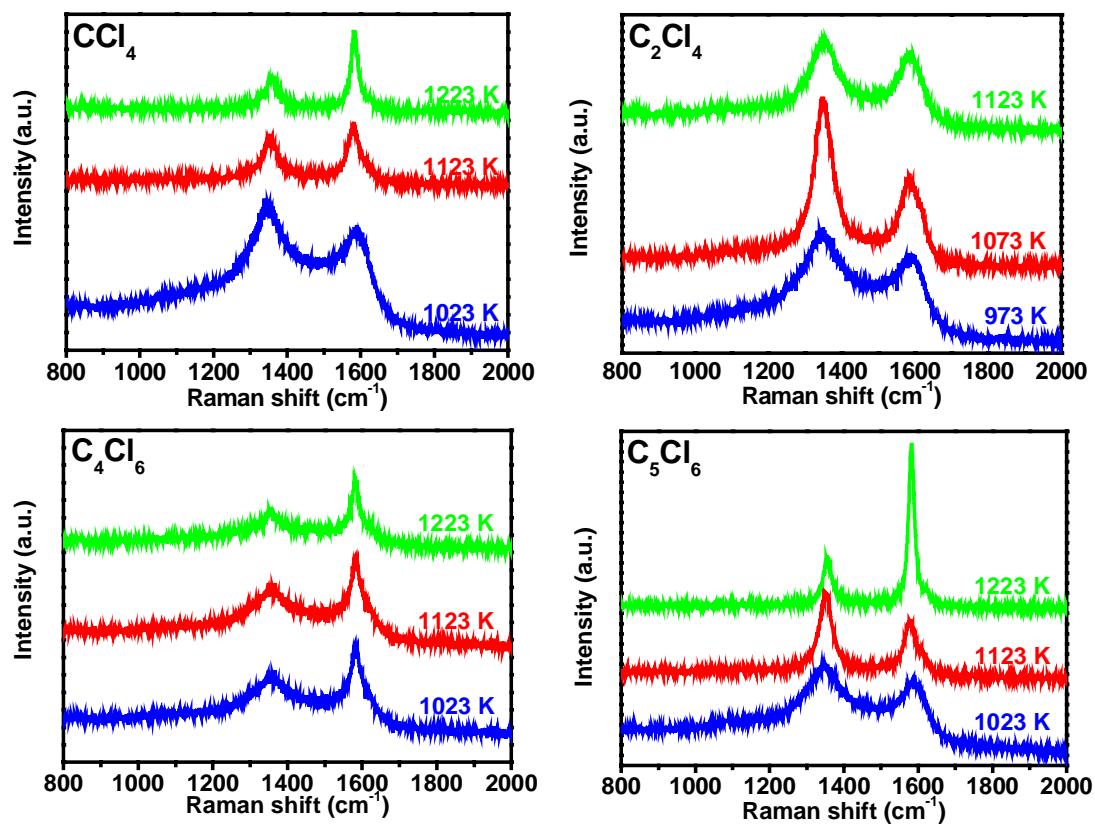


$\text{CCl}_4$	(A) 1023 K	(B) 1123 K	(C) 1223 K
$\text{C}_2\text{Cl}_4$	(D) 973 K	(E) 1023 K	(F) 1123 K
$\text{C}_4\text{Cl}_6$	(G) 1023 K	(H) 1123 K	(I) 1223 K
$\text{C}_5\text{Cl}_6$	(J) 1023 K	(K) 1123 K	(L) 1223 K

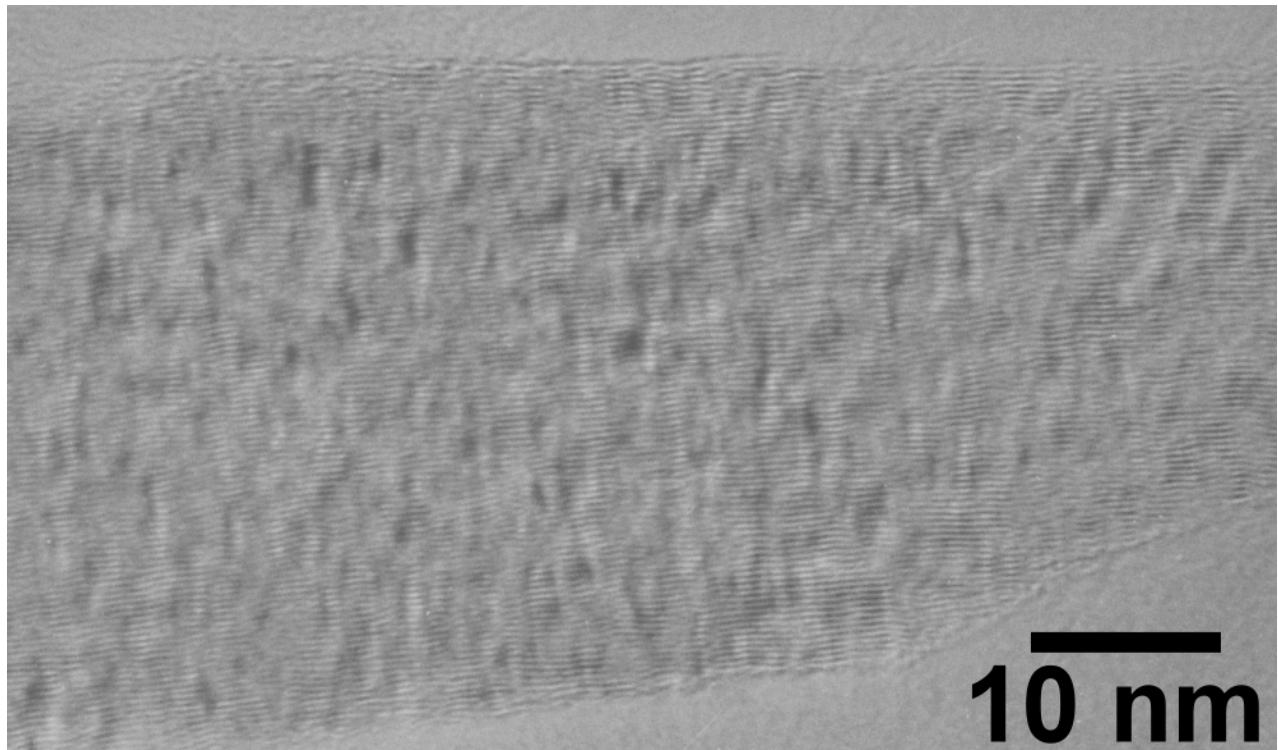
**Figure S3.** TEM images of graphite products prepared from  $\text{CaC}_2$  and  $\text{C}_x\text{Cl}_y$  at different temperatures.



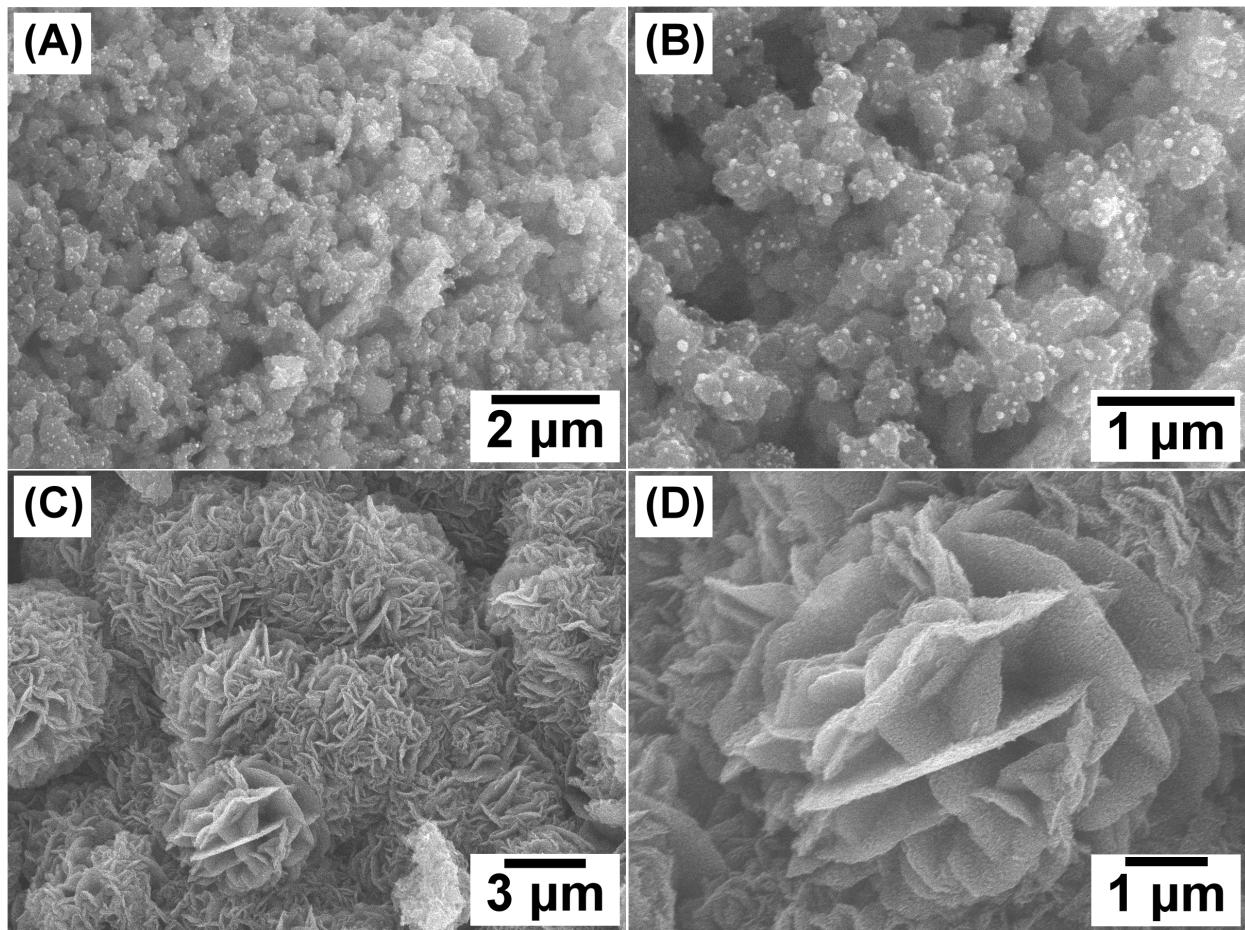
**Figure S4.** XRD of graphite products grown at 973 K – 1223 K from  $\text{CaC}_2$  and  $\text{C}_x\text{Cl}_y$ .



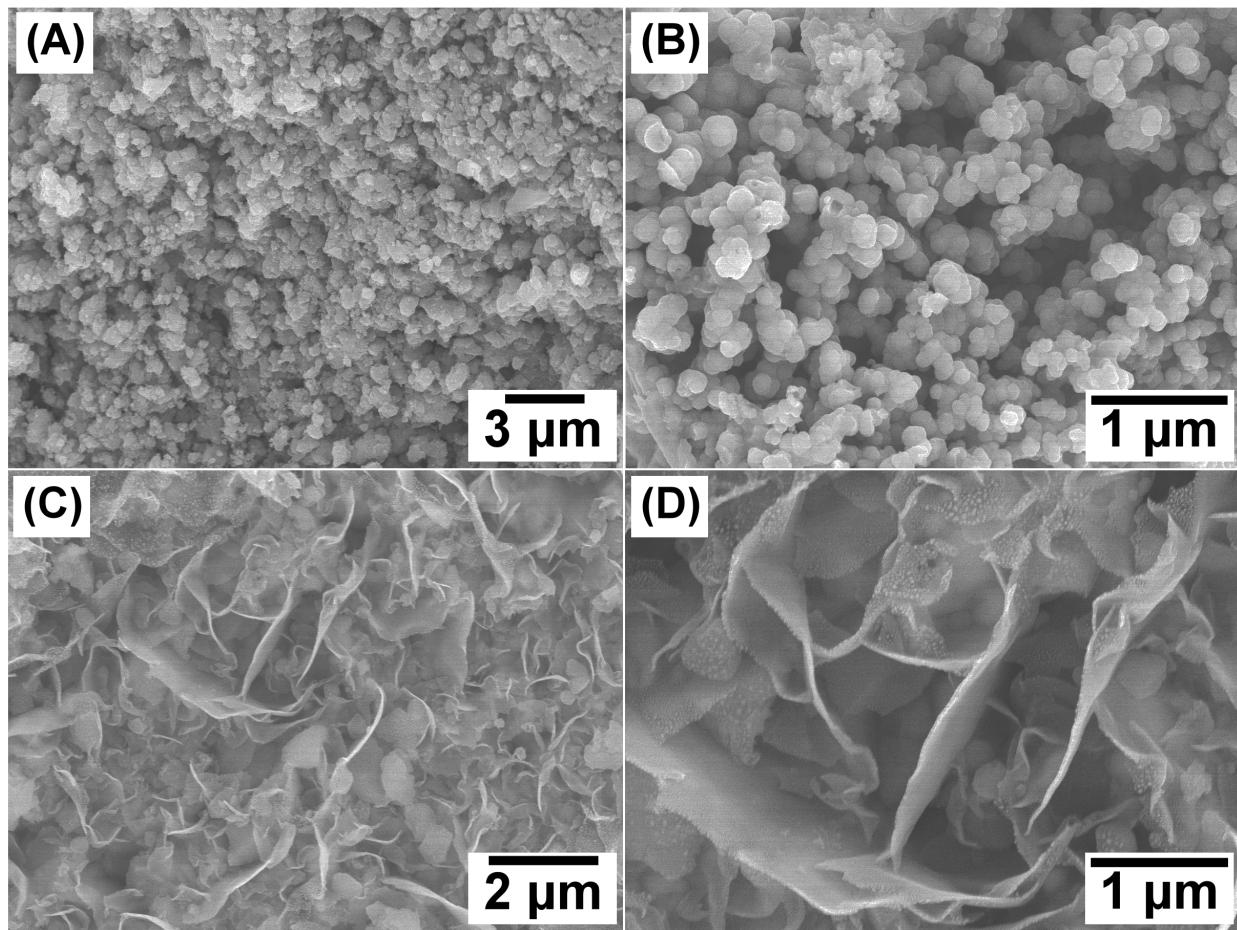
**Figure S5.** Raman spectra of graphite products grown at 973 K – 1223 K from  $\text{CaC}_2$  and  $\text{C}_x\text{Cl}_y$ .



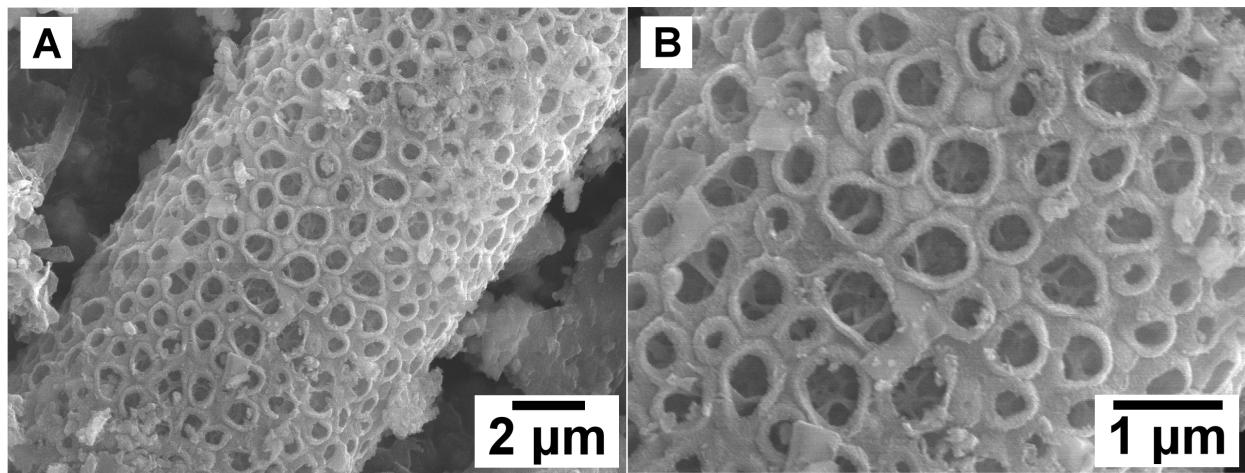
**Figure S6.** HRTEM of a sample prepared from  $\text{CaC}_2$  and  $\text{C}_4\text{Cl}_6$  at 1023 K, showing nearly one hundred graphene layers.



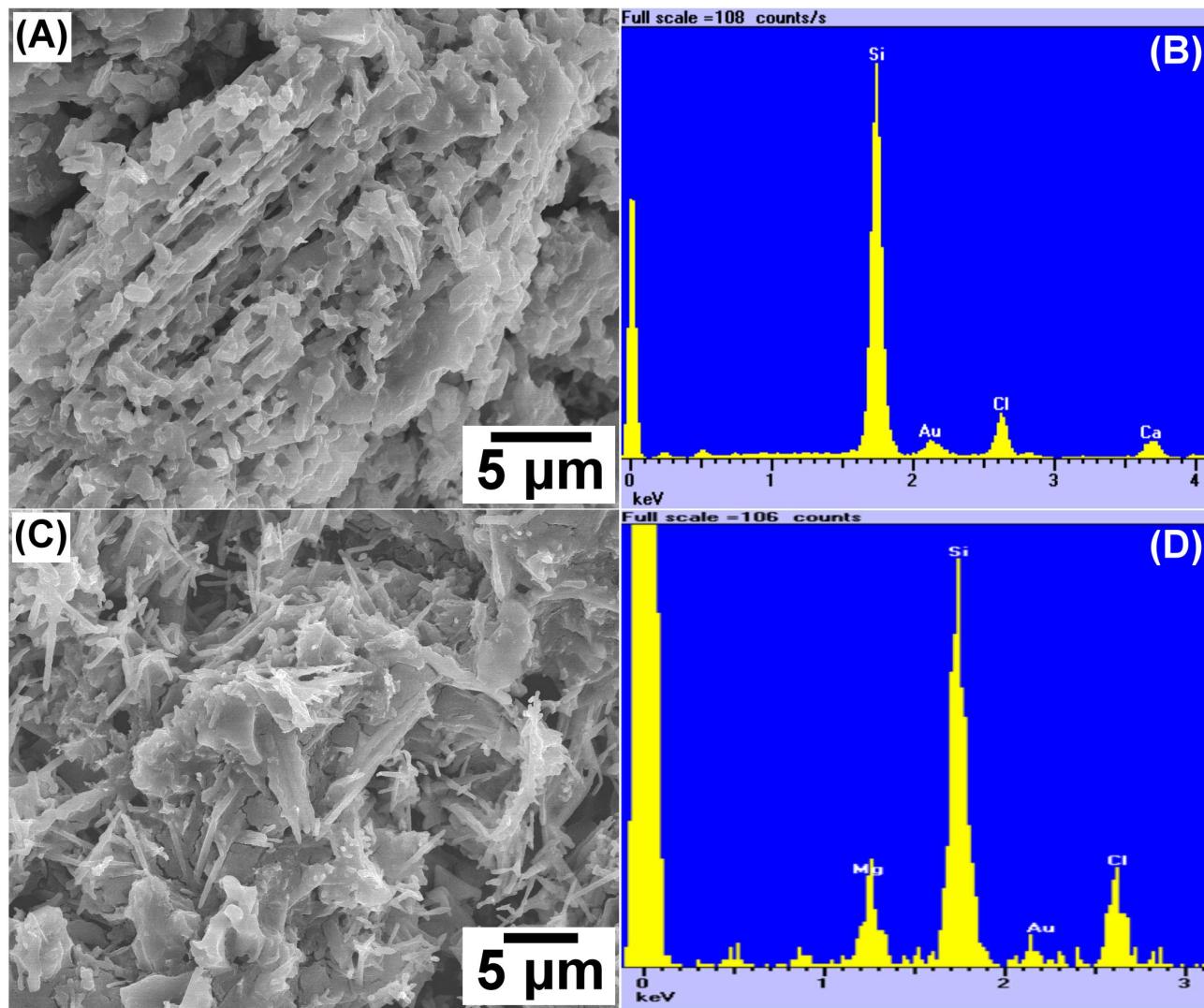
**Figure S7.** SEM images of products prepared from  $\text{CaC}_2$  and  $\text{Br}_2$ . (A) Low and (B) high magnification carbon particles, prepared at 1023 K; (C) Low and (D) high magnification planar carbon, prepared at 1223 K.



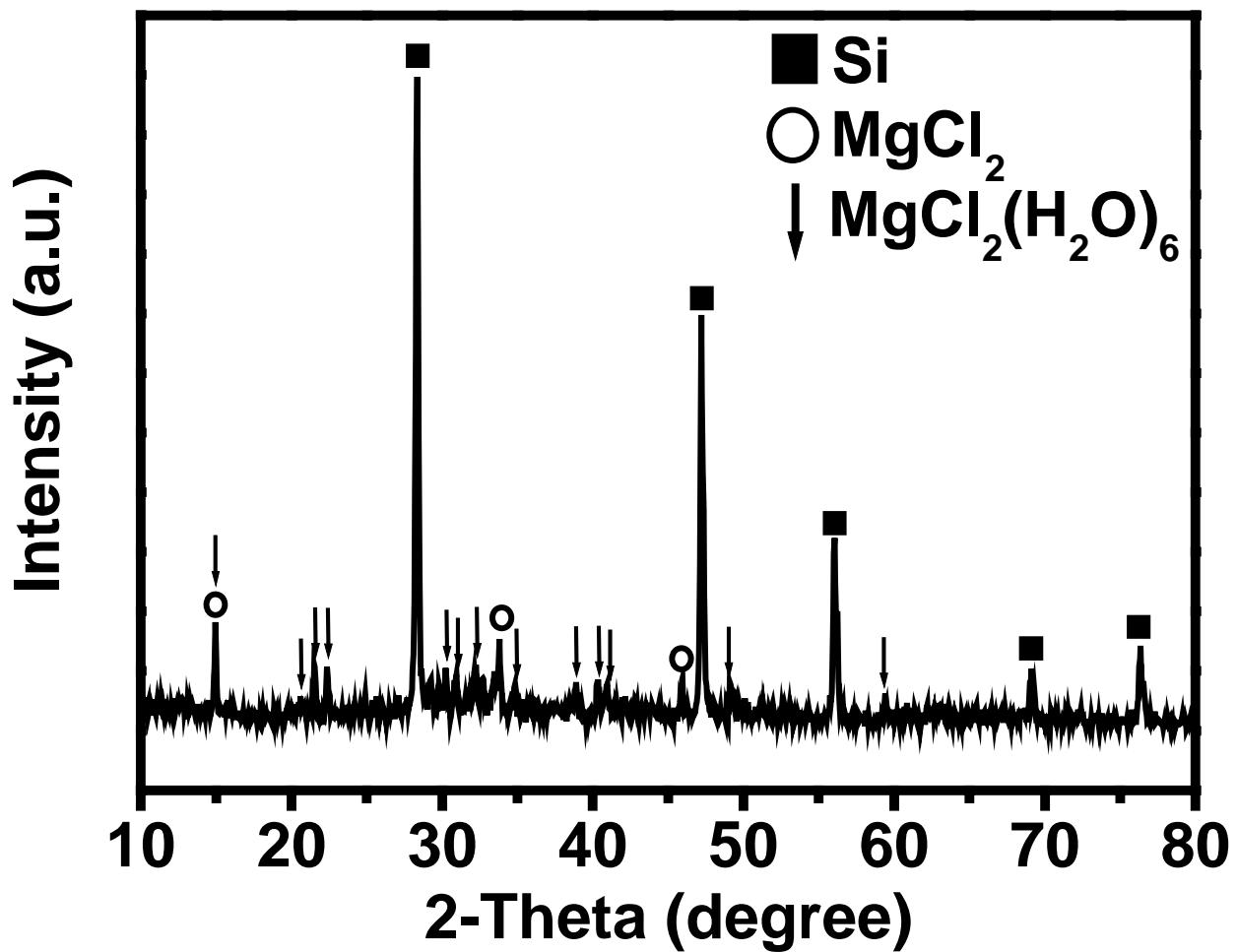
**Figure S8.** SEM images of products prepared from  $\text{CaC}_2$  and  $\text{I}_2$ . (A) Low and (B) high magnification carbon particles, prepared at 1023 K; (C) Low and (D) high magnification planar carbon, prepared at 1223 K.



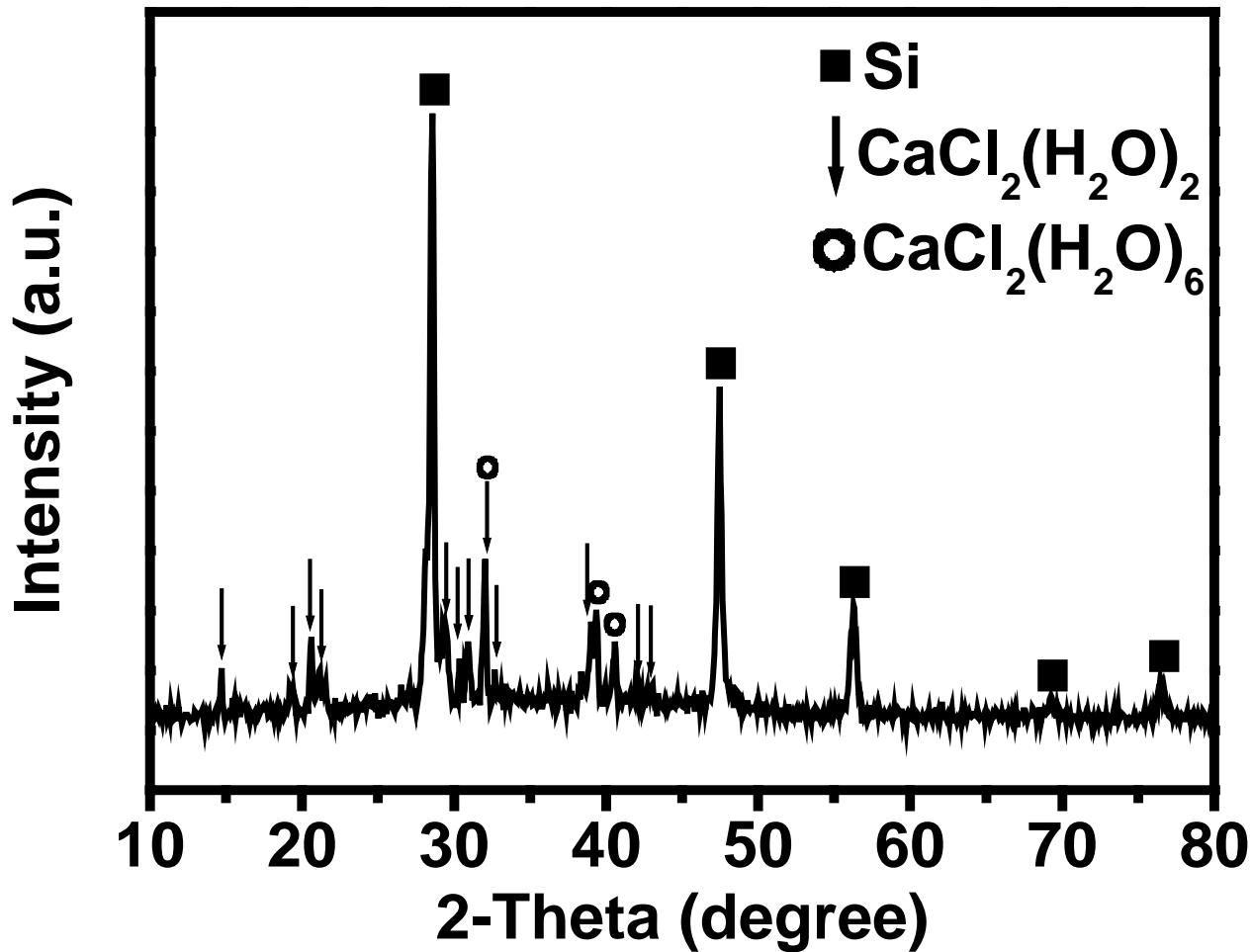
**Figure S9.** SEM images of products prepared from  $\text{CaC}_2$  and  $\text{C}_6\text{Cl}_6$ . (A) Low and (B) high magnification porous carbon, prepared at 1023 K.



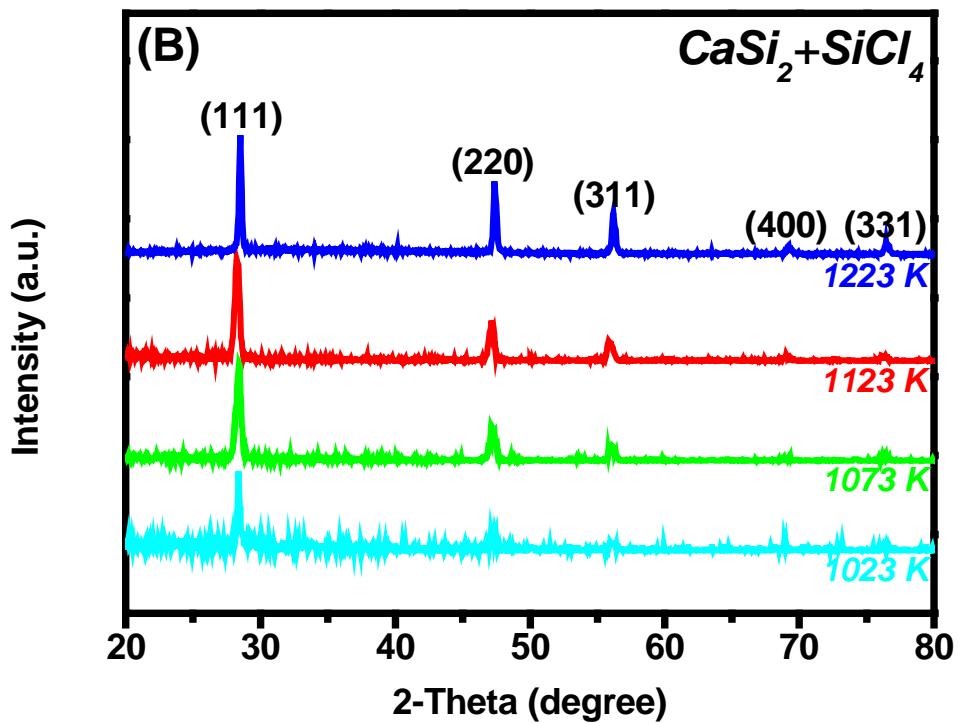
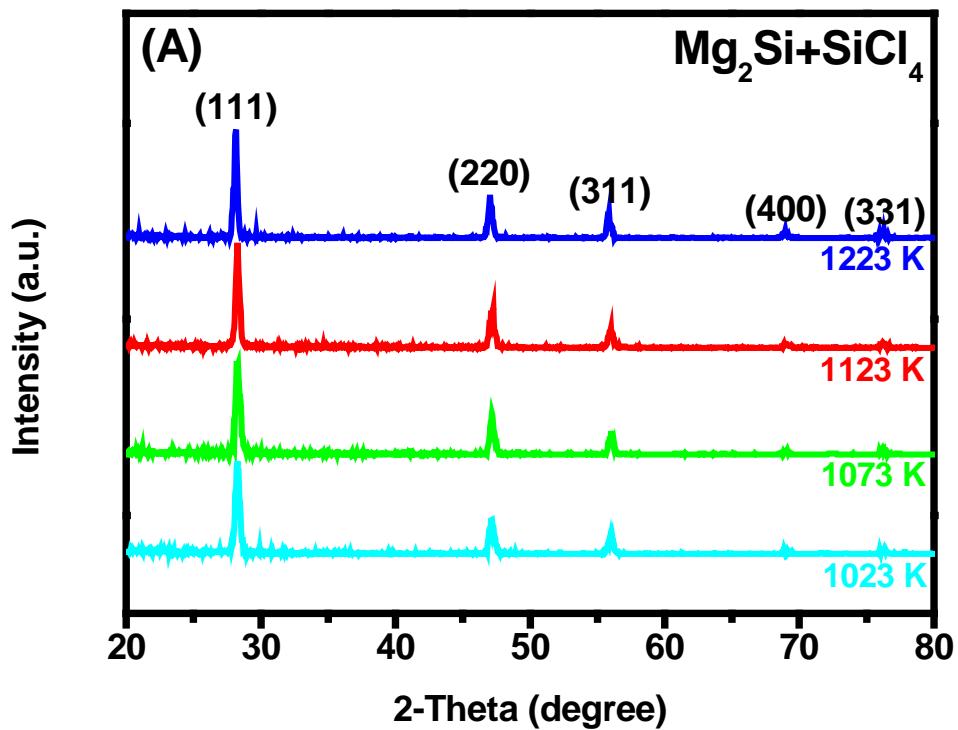
**Figure S10.** (A) SEM and (B) EDX of products synthesized from  $\text{SiCl}_4$  and  $\text{CaSi}_2$  at 1123 K showing formation of Si and  $\text{CaCl}_2$ . (C) SEM and (D) EDX of products synthesized from  $\text{SiCl}_4$  and  $\text{Mg}_2\text{Si}$  at 1123 K showing formation of Si and  $\text{MgCl}_2$ .



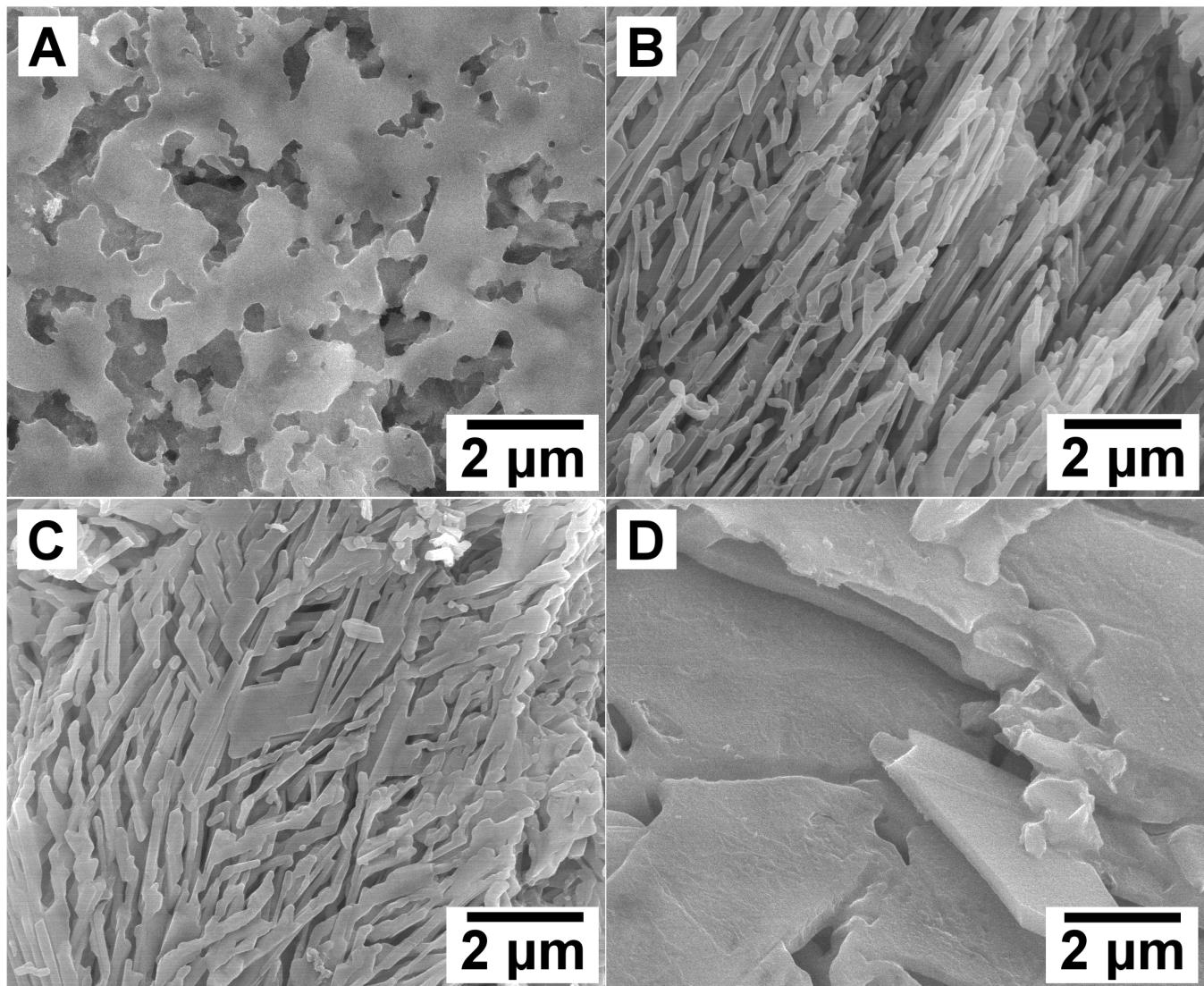
**Figure S11.** XRD of products grown from SiCl<sub>4</sub> and Mg<sub>2</sub>Si at 1123 K showing formation of Si, MgCl<sub>2</sub> and MgCl<sub>2</sub>(H<sub>2</sub>O)<sub>6</sub>. JCPDS file number: Si, 89-5012; MgCl<sub>2</sub>, 89-1567; MgCl<sub>2</sub>(H<sub>2</sub>O)<sub>6</sub>, 74-1039.



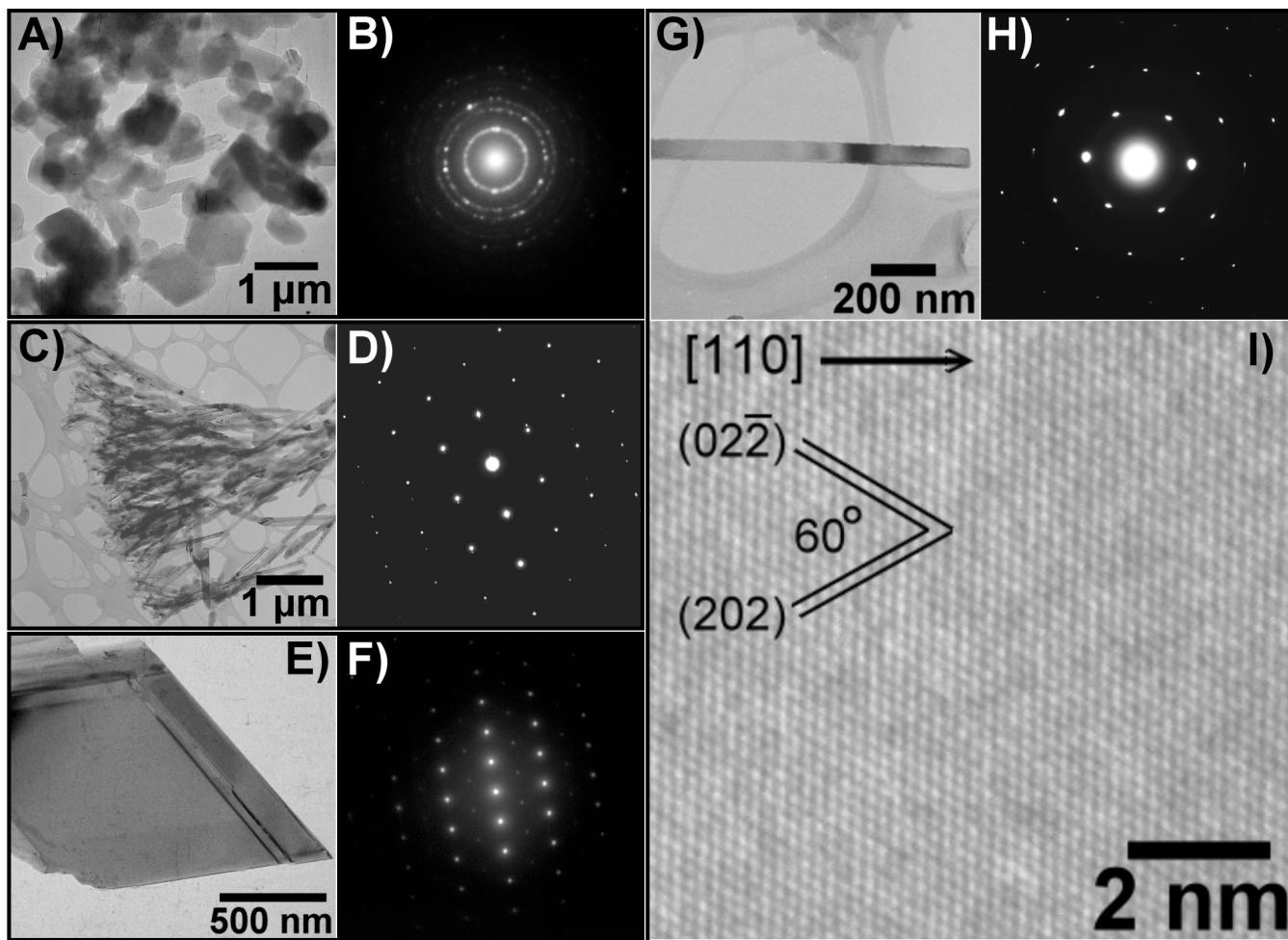
**Figure S12.** XRD of products grown from  $\text{SiCl}_4$  and  $\text{CaSi}_2$  at 1123 K showing formation of Si and  $\text{CaCl}_2(\text{H}_2\text{O})_x$ . JCPDS file number: Si, 89-5012;  $\text{CaCl}_2(\text{H}_2\text{O})_2$ , 70-0385;  $\text{CaCl}_2(\text{H}_2\text{O})_6$ , 77-1782.



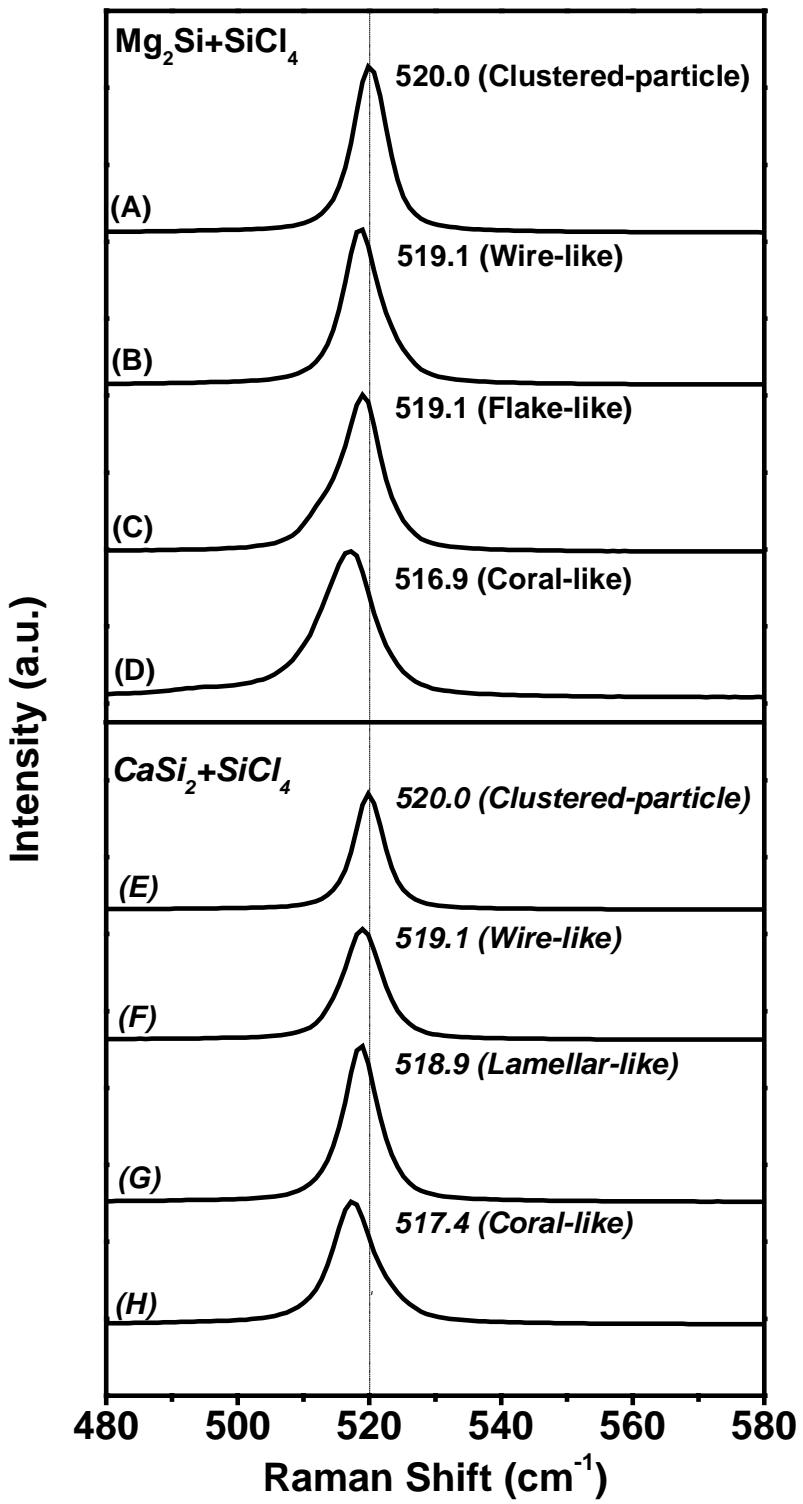
**Figure S13.** XRD of silicon products grown at 1023 K – 1223 K from  $\text{SiCl}_4$  and (A)  $\text{Mg}_2\text{Si}$ , (B)  $\text{CaSi}_2$  after removal of the salts. JCPDS file number: Si, 89-5012.



**Figure S14.** SEM images of silicon products prepared from  $\text{CaSi}_2$  and  $\text{SiCl}_4$ . (A) Porous silicon, prepared at 1023 K; (B) silicon nanowires, prepared at 1073 K; (C) coral-like silicon, prepared at 1123 K; (D) planar silicon, prepared at 1223 K.



**Figure S15.** Various morphology of silicon products prepared from  $\text{CaSi}_2$  and  $\text{SiCl}_4$ . (A) TEM image and (B) SAED of porous structure prepared at 1023 K; (C) TEM image and (D) SAED taken along the [0 1 1] zone axis of coral-like silicon prepared at 1123 K; (E) TEM image and (F) SAED taken along the [1 -1 -2] zone axis of planar silicon prepared at 1223 K; (G) TEM (low magnification) image and (H) SAED taken along the [-1 1 1] zone axis and (I) HRTEM image of a single silicon nanowire prepared at 1073 K.



**Figure S16.** Raman spectra of Si products with different structures prepared from  $\text{SiCl}_4$  and  $\text{Mg}_2\text{Si}$  at (A) 1023 K, (B) 1073 K, (C) 1123 K, (D) 1223 K; and  $\text{CaSi}_2$  at (E) 1023 K, (F) 1073 K, (G) 1123 K, (H) 1223 K.

